

Data sheet acquired from Harris Semiconductor SCHS066C- Revised October 2003

## CMOS 8-Bit Addressable Latch

High-Voltage Types (20-Volt Rating)

■ CD4099B 8-bit addressable latch is a serial-input, parallel-output storage register that can perform a variety of functions.

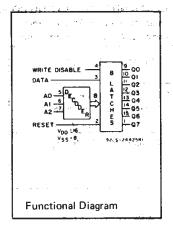
Data are inputted to a particular bit in the latch when that bit is addressed (by means of inputs A0, A1, A2) and when WRITE DISABLE is at a low level. When WRITE DISABLE is high, data entry is inhibited; however, all 8 outputs can be continuously read independent of WRITE DISABLE and address inputs.

A master RESET input is available, which resets all bits to a logic "0" level when RESET and WRITE DISABLE are at a high level. When RESET is at a high level, and WRITE DISABLE is at a low level, the latch acts as a 1-of-8 demultiplexer; the bit that is addressed has an active output which follows the data input; while all unaddressed bits are held to a logic "0" level.

The CD4099B types are supplied in 16-lead hermetic ceramic dual-in-line packages (F3A suffix), 16-lead plastic dual-in-line packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

#### Features:

- Serial data input Active parallel output
- Storage register capability Master clea
- Can function as demultiplexer
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V (full package-temperature range), 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) = 1 V at V<sub>DD</sub> = 5 V, 2 V at V<sub>DD</sub> = 10 V, 2.5 V at V<sub>DD</sub> = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Séries CMOS Devices"



CD4099B Types

#### Applications:

- Multi-line decoders
- A/D converters

MAXIMUM RATINGS, Absolute-Maximum Values:	10 A
DC SUPPLY-VOLTAGE RANGE, (VDD)	
Voltages referenced to V <sub>SS</sub> Terminal)	0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS	0.5V to V <sub>DD</sub> +0.5V
DC INPUT CURRENT, ANY ONE INPUT	±10mA
POWER DISSIPATION PER PACKAGE (PD):	
For T <sub>A</sub> = -55°C to +100°C	500mW
For T <sub>A</sub> = +100°C to +125°C Derate Li	nearity at 12mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	100mW
OPERATING-TEMPERATURE RANGE (TA)	55°C to +125°C
STORAGE TEMPERATURE RANGE (Tato)	65°C to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	e de la compa

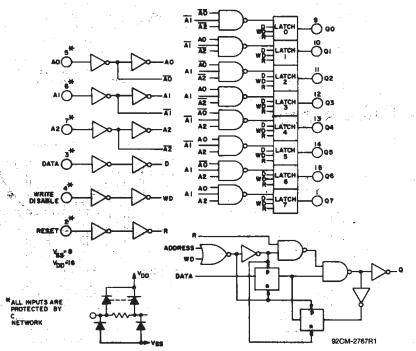
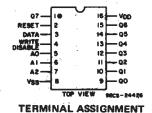


Fig. 1 — Logic diagram of CD4099B and detail of 1 of 8 latches.



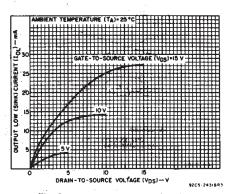


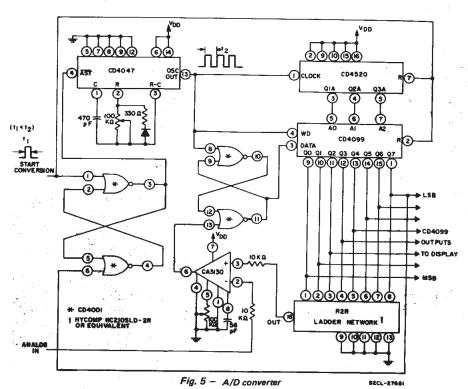
Fig. 2 — Typical output low (sink) current characteristics.

**RECOMMENDED OPERATING CONDITIONS** at  $T_A = 25^{\circ}$  C (Unless otherwise specified) For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

CHARACTERISTIC	SEE	$v_{DD}$	LIN	ITS	UNITS
	FIG. 15*	(V)	MIN.	MAX.	OMIIS
Supply Voltage Range: (At T <sub>A</sub> = Full Package Temperature Range)			3	18	٧.
Minimum Pulse Width, tW		5	200	-	
Data	(4)	10	100	_	
		15	80		٠.
		5	400	_	
Address	(8)	10	200		ns
		15	125	<u> </u>	
		5	150	. –	
Reset	(5)	10	75	_	. ,
		15	50	_	
Setup Time, t <sub>S</sub>		5	100	_	
Data to WRITE DISABLE	(6)	10	50	. –	
		15	35	-	ns
Hold Time, tH		5	150	_	
Data to WRITE DISABLE		10	75	· _	ns
		15	50	_	

<sup>\*</sup> Circled numbers refer to times indicated on master timing diagram.

Note: In addition to the above characteristics, a WRITE DISABLE ON time (the time that WRITE DISABLE is at a high level) must be observed during an address change for the total time that the external address lines AO, A1, and A2 are settling to a stable level, to prevent a wrong cell from being addressed (see Fig. 3).



	MODE SELECTION												
WD	R	ADDRESSED LATCH	UNADDRESSED LATCH										
0	0	Follows Data	Holds Previous State										
0	1	Follows Data (Active High 8	Reset to "0" -Channel Demulti- plexer)										
1	0	Holds Pr	evious State										
1	1	Reset to "0"	Reset to "0"										

WD = WRITE DISABLE

R = RESET

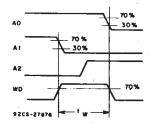


Fig. 3 - Definition of WRITE DISABLE ON time.

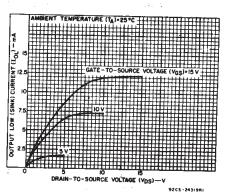


Fig. 4 — Minimum output low (sink) current characteristics.

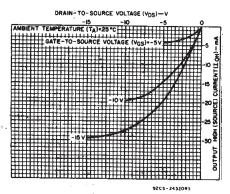
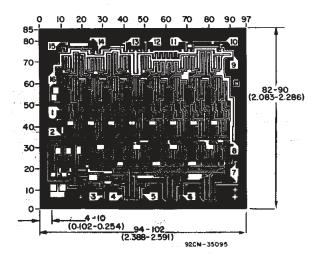


Fig. 6 - Typical output high (source) current characteristics.

#### STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	COND	ITION	IS	LIMIT	rs at i	NDICAT	ED TEN	IPERA	rures (	°C)	UNITS
ISTIC	Vo.	VIN	$v_{DD}$			.05	.455		+25		Olaris
	(V)	(V)	(V)	-55	<del>-40</del>	+85	+125	Min.	Тур.	Max.	:
Quiescent Device		0,5	5	5	5	150	150	<b>*</b> -	0.04	5	
Current,	<u> </u>	0,10	10	10	10	300	300	_	0.04	10	μА
IDD Max.	. –	0,15	15	20	20	600	600		0.04	20	μ
	-	0,20	20	100	100	3000	3000	-	0.08	100	
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1		_
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	<b>-</b> .	
Output High (Source) Current,	1.5	0,15	15	4.2	4	2.8	2.4	3 4	6.8	_	
	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	-	mA
	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2		
	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	
IOH Min.	13.5	0,15	15	-4.2	4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage:	90 <u> </u>	0,5	5		0	.05		-	0	0.05	
Low-Level,	-	0,10	10		0	.05		-	0	0.05	
VOL Max.	_	0,15	15		0	.05		-	0	0.05	v
Output Voltage:	-	0,5	5		4	.95		4.95	5	-	ľ
High-Level,	-	0,10	10		9	.95		9.95	10.	-"	
VOH Min.	-	0,15	15		14	1.95		14.95	15	_	
Input Low	0.5, 4.5		5		1	1.5		_	_	1.5	
Voltage,	1, 9	_	10			3		_	_	3	
VIL Max.	1.5,13.5	_	15			4		_	_	4	
Input High	0.5, 4.5	-	5		:	3.5		3.5	_	-	\ \
Voltage,	1, 9	_	10			7		7			
VIH Min.	1.5,13.5	-	15			11		11		_	
Input Current IN Max.		0,18	18	±0.1	±0.1	,±1	±1	-	±10-5	±0,1	μА



## CD4099BH DIMENSIONS AND PAD LAYOUT

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10<sup>-3</sup> inch).

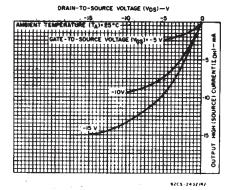


Fig.7 - Minimum output high (source) current characteristics.

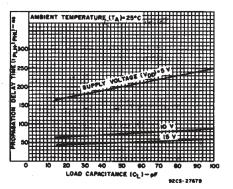


Fig. 8 - Typical propagation delay time (deta to Qn) vs. load capacitance.

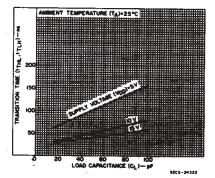


Fig. 9 — Typical transition time vs. load capacitance.

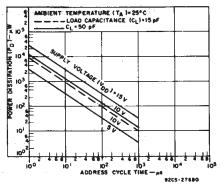


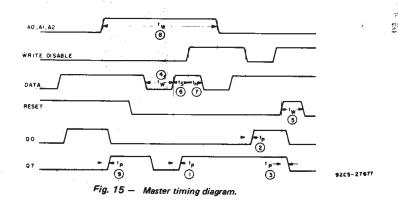
Fig. 10 — Typical dynamic power dissipation vs. address cycle time.

#### CD4099B Types

# DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A$ = 25° C, $C_L$ = 50 pF, Input $t_F$ , $t_f$ = 20 ns, $R_L$ = 200 K $\Omega$

CHARACTERIS	STIC	CONDI SEE FIG.15*	V <sub>DD</sub>	1	AITS KAGE TYPES MAX.	UNITS	
Propagation Delay:	tpi H,		5	200	400		
	<sup>‡</sup> PHL	1	10	75	150	·	
Data to Output,			15	50	100	-	
WRITE DISABL	.E		5	200	400		
to Output,	tPLH,	2	10	80	160	ns	
	tPHL		15	60	120		
			5	175	350		
Reset to Outpu	t,	3	10	80	160		
	<sup>t</sup> PHL		15	65	130		
Address to Outpo			5	225	450		
	tPLH,	9	10	100	200		
	<sup>t</sup> PHL		15	75	150		
Transition Time,	tTHL,		- 5	100	200		
(Any Output)	<sup>t</sup> TLH		10	50	100	ns	
	-ILH		15	40	80	115	
Minimum Pulse			5	100	200		
Width, tw		4	10	50	100	ns	
Data			15	40	80	113	
			5	200	400	···· <u>·</u> ····	
Address		(8)	10	100	200	ns	
			15	65	125	115	
			5	75	150		
Reset		(5)	10	40	75	ns	
2	.5		15	25	50	113	
Minimum Setup			5	50	100		
Time, tg	4 % M	6	10	25	50	ns	
Data to WRITE DIS	ABLE		15	20	35	113	
Minimum Hold	3	-	- 5	75	150		
Time, t <sub>H</sub>		0	10	40	75	ns	
Data to WRITE DIS	ABLE		15	25	50	112	
Input Capacitance,		Any Inp		5	7.5	pF	

<sup>\*</sup>Circled numbers refer to times indicated on master timing diagram.



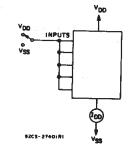


Fig. 11 — Quiescent device current test circuit.

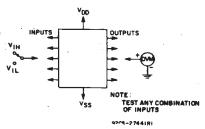


Fig. 12 - Input voltage test circuit.

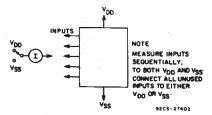


Fig. 13 - Input current test circuit.

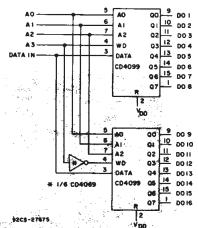


Fig. 14 - 1 of 16 decoder/demuttelexer.

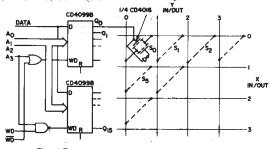


Fig. 16 — Multiple selection decoding — 4 x 4 crosspoint switch.

www.ti.com 14-Oct-2022

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CD4099BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4099BE	Samples
CD4099BF	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4099BF	Samples
CD4099BF3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4099BF3A	Samples
CD4099BM	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099BM	Samples
CD4099BM96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099BM	Samples
CD4099BNSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099B	Samples
CD4099BPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM099B	Samples
JM38510/17601BEA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17601BEA	Samples
M38510/17601BEA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17601BEA	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE**: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

### PACKAGE OPTION ADDENDUM

www.ti.com 14-Oct-2022

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF CD4099B, CD4099B-MIL:

Catalog: CD4099B

Military: CD4099B-MIL

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

• Military - QML certified for Military and Defense Applications

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 9-Aug-2022

#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

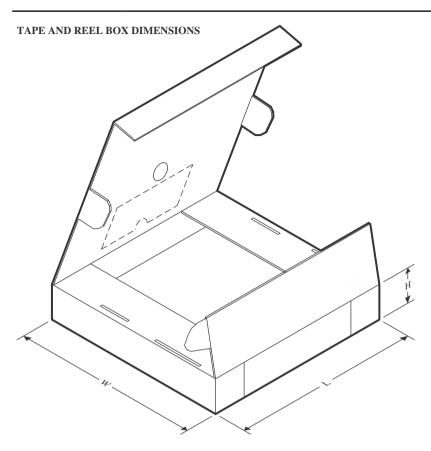
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4099BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD4099BNSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4099BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

www.ti.com 9-Aug-2022



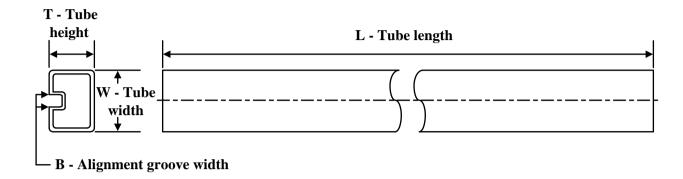
#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4099BM96	SOIC	D	16	2500	340.5	336.1	32.0
CD4099BNSR	SO	NS	16	2000	356.0	356.0	35.0
CD4099BPWR	TSSOP	PW	16	2000	356.0	356.0	35.0

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 9-Aug-2022

#### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD4099BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4099BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4099BM	D	SOIC	16	40	507	8	3940	4.32



SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOF



#### NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOP



#### NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



## D (R-PDS0-G16)

#### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



## D (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

## 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## N (R-PDIP-T\*\*)

### PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



### 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

#### **IMPORTANT NOTICE AND DISCLAIMER**

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022, Texas Instruments Incorporated